

# Direct Sampling Methods for General Nonlinear Inverse Problems

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Joint work with

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# OUTLINE

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- ◆ Motivation of sampling-type methods
- ◆ General framework of direct sampling methods
- ◆ DSMs for Inverse acoustic/EM scattering, EIT, DOT
- ◆ **DSMs for moving inhomogeneous media**
- ◆ Optimal control approach for Sobolev scale

# Most Popular Approach for Inverse Problems

- ◆ Most IPs: parameter identifications in PDEs, e.g.,  
EIT, DOT, Inverse Scattering, Seismic Tomography, ...

Stationary PDE:

$$L_q(u) = 0$$

or time-dependent PDE:

$$D_t^\alpha u - L_q(u) = 0$$

Inverse problem is to solve

$$u(q) = u^\delta \quad \text{on } \Gamma$$

Mostly the solution parameter  $q$  tells us information

geometric shape/location & distributional values

# Least-squares formulation with regularization

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◆ **IPs are mostly ill-posed:**  $u(q) = u^\delta$  on  $\Gamma$

**transform to a nearby “well-posed” problem:**

$$\min_{q \in K} J(q) = \text{data fitting } (u(q) - u^\delta) + \beta \Phi(q)$$

◆ **A most crucial mathematical issue :**

choose  $K, \Phi, \beta$  s.t. it is stable wrt data

# Solution of Nonlinear Optim Systems

◆ Output LS Tikhonov regularization :

$$\min_{q \in K} J(q) = \text{data fitting } (u(q) - u^\delta) + \beta \Phi(q)$$

◆ 1<sup>st</sup> approach: coupled optimality PDE system

{ Forward PDE ;  
Adjoint PDE ;  
Variational Inequality

➔ Singularities: parameters mostly disconts, unknown

e.g., conductivity in EIT, refractive index in inverse medium

# Iterative Solvers for Nonlinear Optim Systems

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◆ Least-squares minimization :

$$\min_{q \in K} J(q) = \text{data fitting } (u(q) - u^\delta) + \beta \Phi(q)$$

highly nonlinear, nonconvex, nonsmooth

◆ **2<sup>nd</sup> approach: iterative**

**Most popular iterative, e.g., Newton type:**

need to choose  $\beta$ ,  $h$ ,  $\Delta t$ ,

need good initial guess of  $q$ ,

repeated forward solutions,

need the derivatives of  $u(q)$  wrt changes of  $q$

often very sensitive to noise



Often very expensive & challenge to solve

◆ **Is it always worthwhile or necessary to do so?**

# Alternative Solvers

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◆ Indeed not worthwhile or necessary to do

$$\min_{q \in K} J(q) = \text{data fitting } (u(q) - u^\delta) + \beta \Phi(q) \quad (1)$$

1<sup>st</sup> : if noise not small, we can see from

$$q - q^{\delta, h} = (q - q^\delta) + (q^\delta - q^{\delta, h}) = O(\delta^\gamma) + O(h^\alpha)$$

2<sup>nd</sup>: no good accuracy needed for the concerned applications

◆ **Alternative solvers, overcoming technical barriers:**

no need good initial guess of  $q$ ,

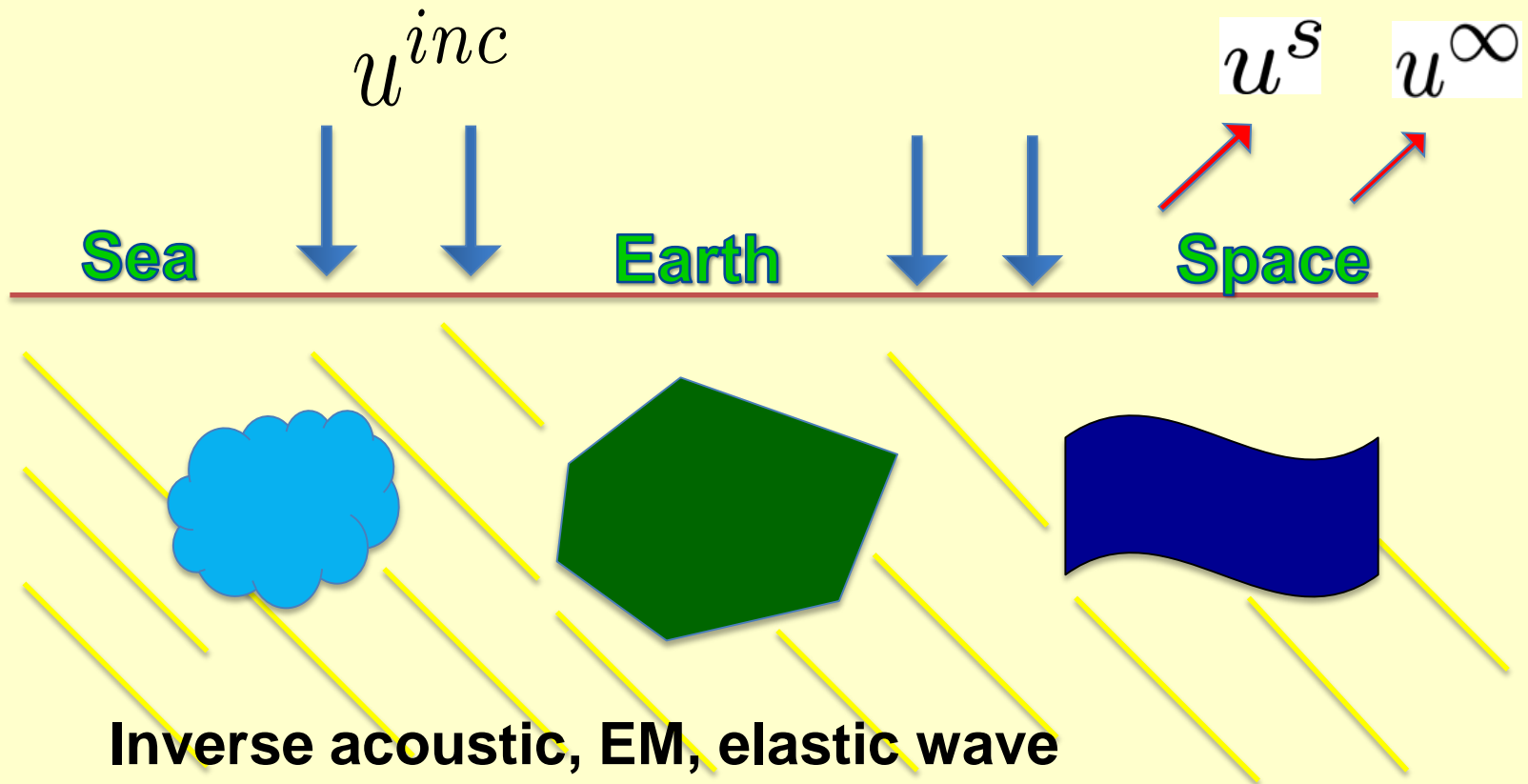
no repeated forward solutions,

no need the derivatives of  $u(q)$  wrt changes of  $q$

**Can we reconstruct**

**Shape & Location, without Physics?**

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**Inverse acoustic, EM, elastic wave**

**EIT, DOT, MRI, ... ..**



# Linear Sampling Method

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◆ Colton-Kirsch 96 : a truly revolutionary algorithm!

Inverse acoustic scattering:  $\Delta u + k^2 n^2(x)u = 0$

◆ Consider the far-field operator  $F : L^2(S^{N-1}) \mapsto L^2(S^{N-1})$

$$(Fg)(\hat{x}) = \int u_\infty(\hat{x}, d) g(d) ds(d), \quad \hat{x} \in S^{N-1}$$

and the far-field equation for  $g$ :

$$Fg = \Phi_\infty(\cdot, z) \quad \forall z \in \mathbb{R}^N$$

◆ Solve for  $g$  at each  $z$ , and look at its energy

$$\|g(\cdot, z)\|_{L^2(S)}$$

# Algorithm of LSM

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◆ Turns inverse scattering into solving integral equations

◆ **Algorithm of LSM** : select a numerical cut-off value  $c$

1. Select a grid  $T_h$  of sampling points, covering  $D$
2. At each  $z$ , solve the far-field equation for  $g(\cdot, z)$
3. Determine

$$z \in D \text{ if } \|g(\cdot, z)\| \leq c;$$

$$z \notin D \text{ if } \|g(\cdot, z)\| > c$$

# Drawbacks of LSM

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- ◆ No effective strategies to choose numerical cut-off values.
- ◆ Huge computational efforts:  
need to solve the far-field equation for each sampling point, e.g.,  
for an  $n \times n \times n$  grid, need to solve  $n^3$  ill-posed equations  
The grid should be very fine to get a fine reconstruction

# New Variants of LSM

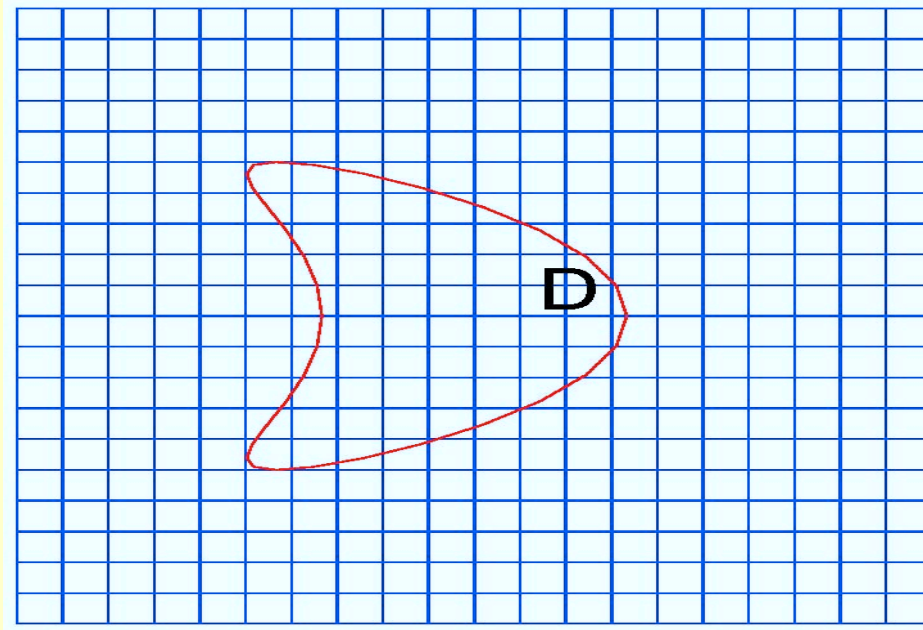
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- ◆ Li-Liu-Zou, SISC 09:  
Multilevel Linear Sampling Method,  
**reduce computational complexity from  $O(n^3)$  to  $O(n^2)$**
- ◆ Li-Liu-Zou, SISC 10:  
Strengthened LSM with a Reference Obstacle,  
**provide a deterministic technique to select feasible numerical cut-off values**

# Multilevel Linear Sampling Method

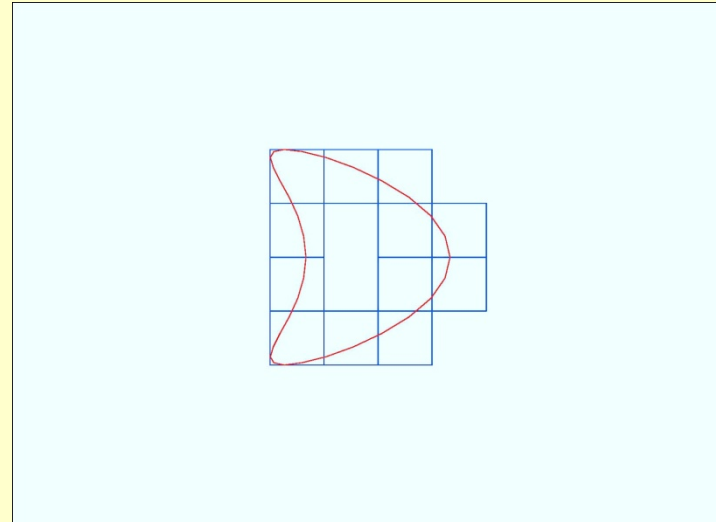
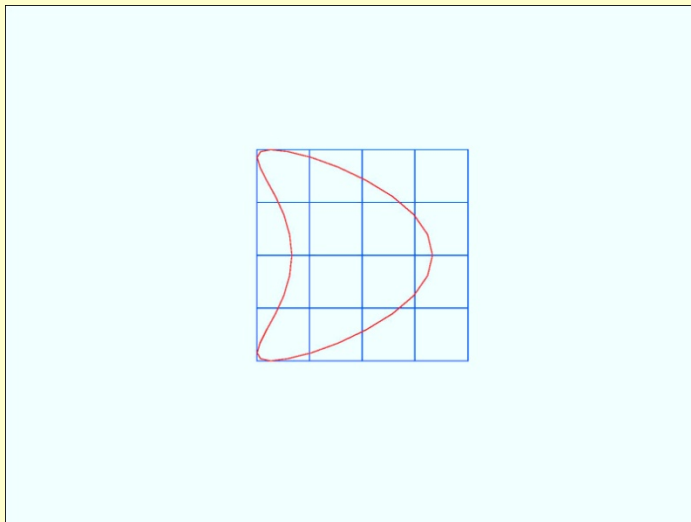
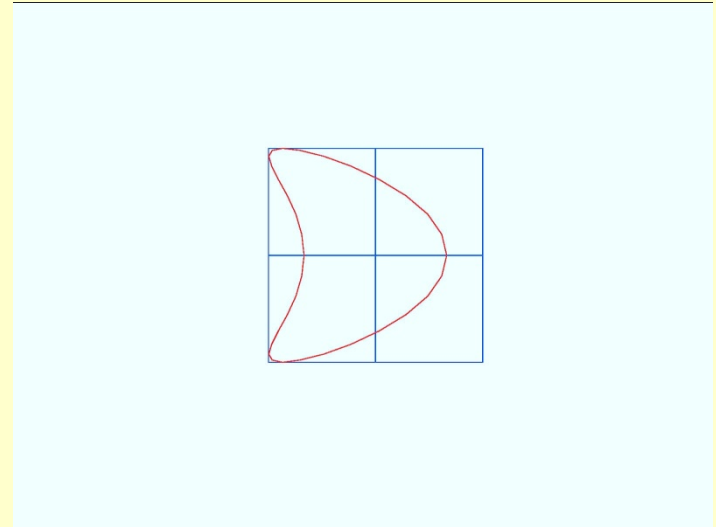
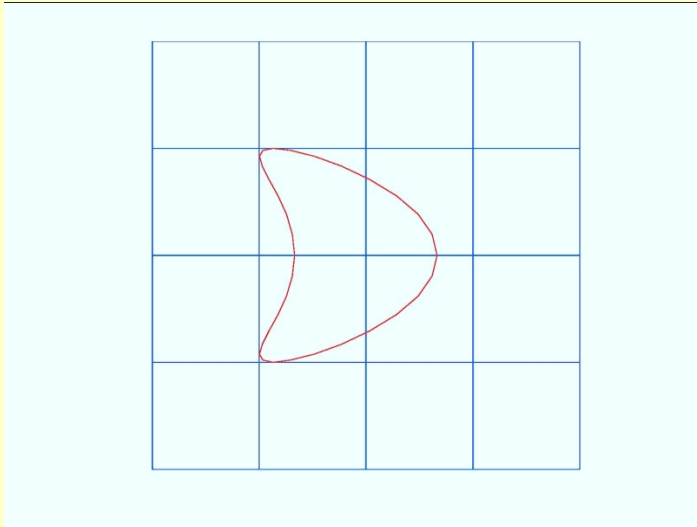
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◆ MLSM : get rid of **remote** and **inner** cells



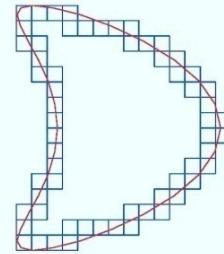
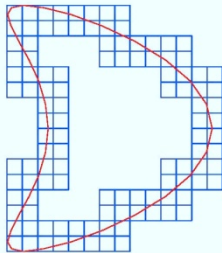
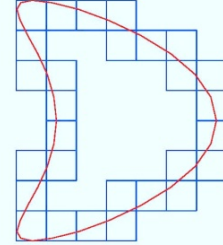
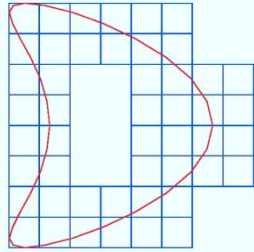
# Numerical Example I

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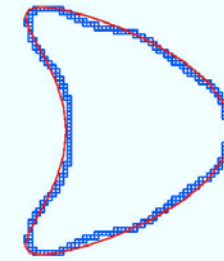
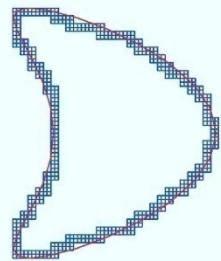
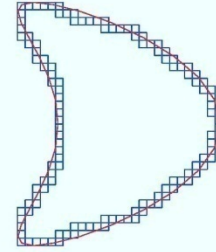
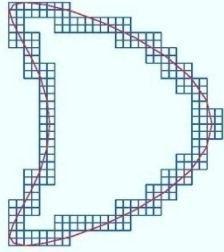
# Numerical Example I

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# Numerical Example I

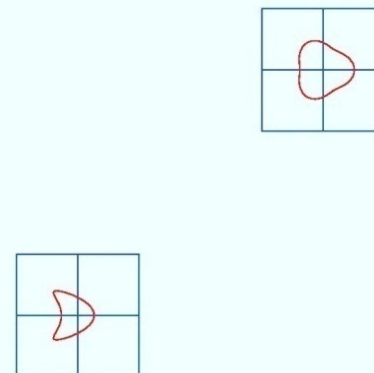
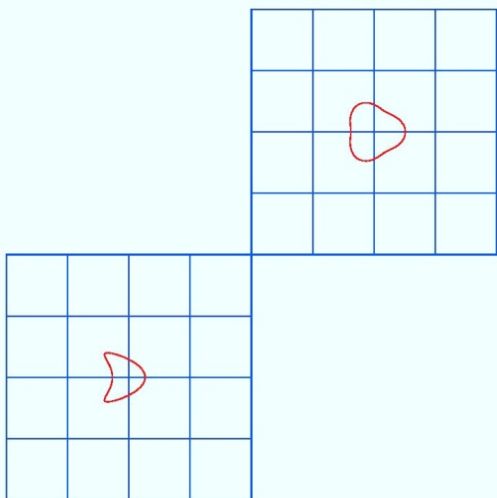
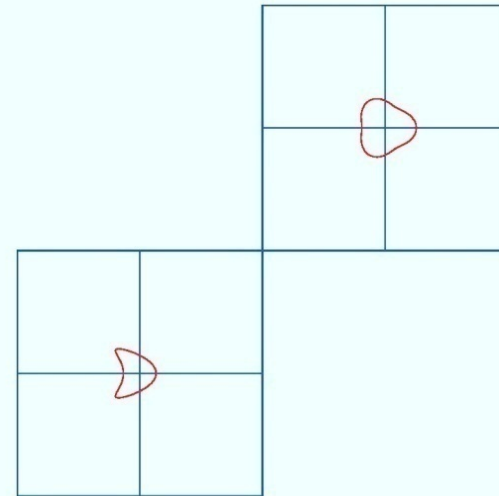
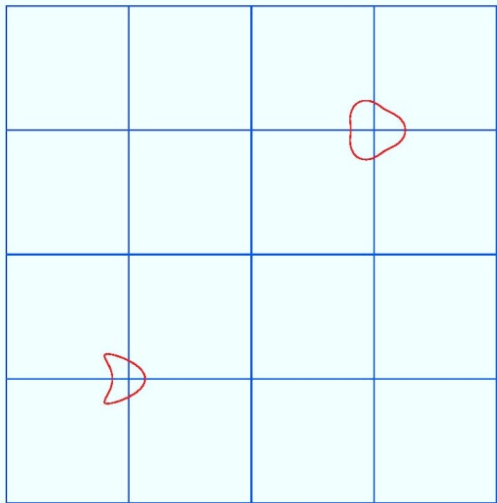
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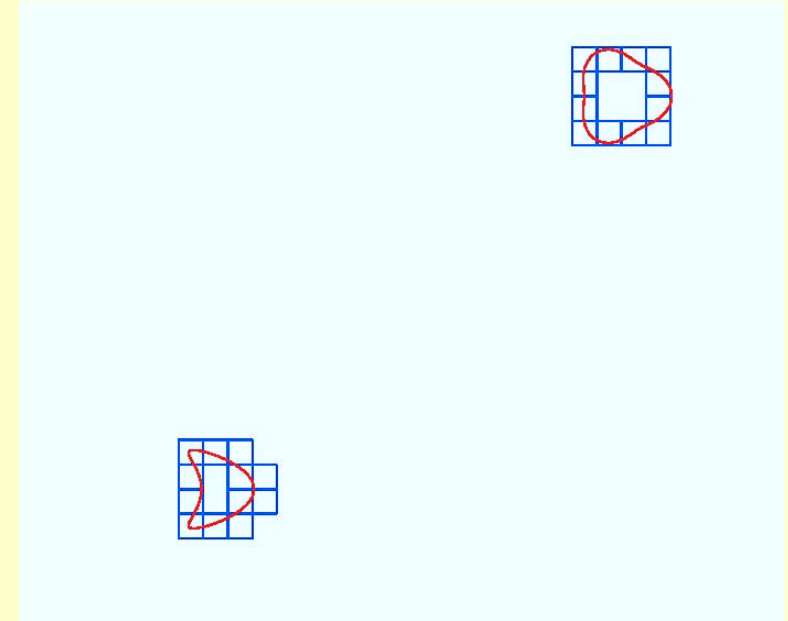
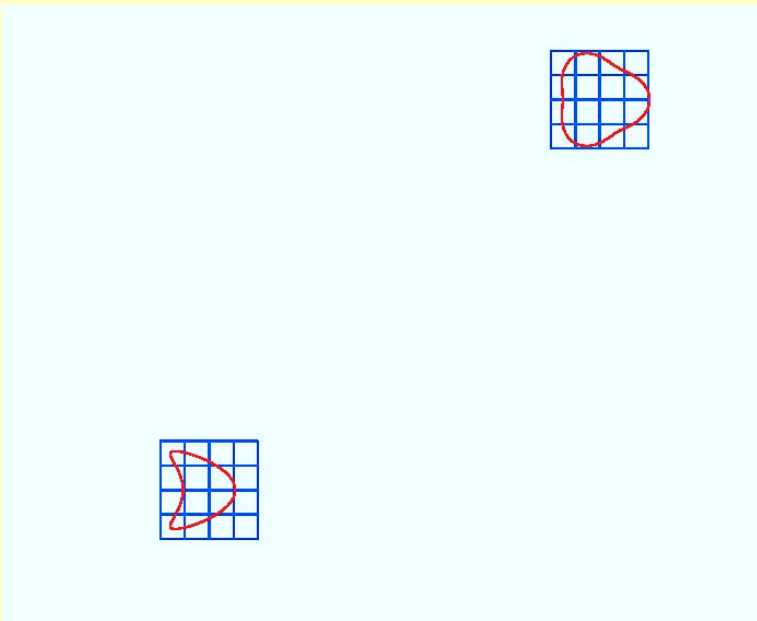
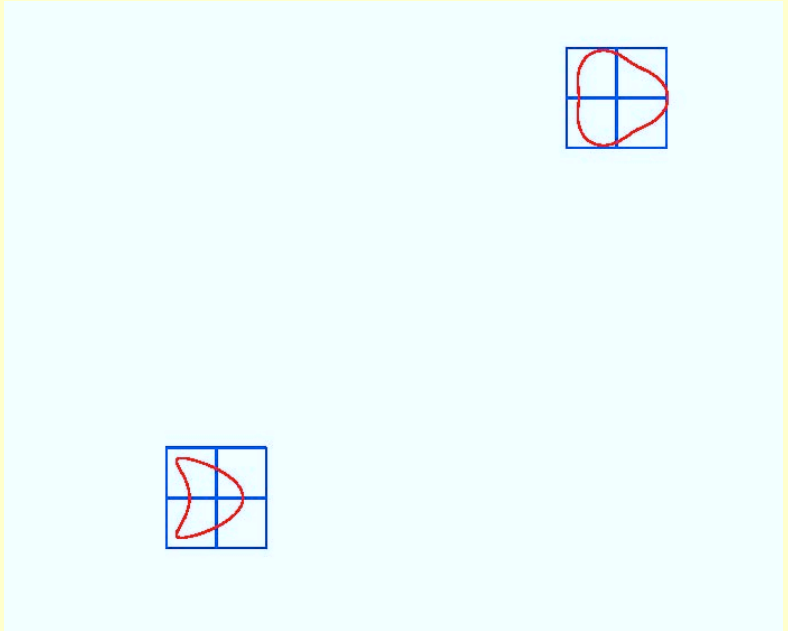
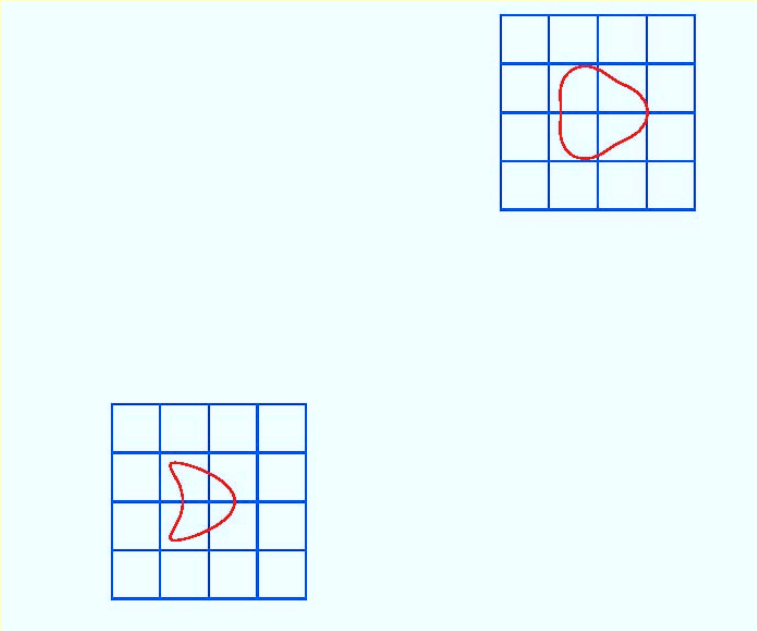
# Numerical Example II

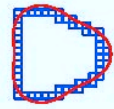
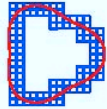
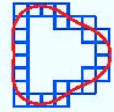
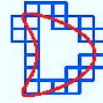
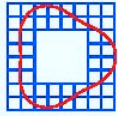
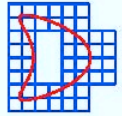
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# Numerical Example II

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# Sampling-type Methods

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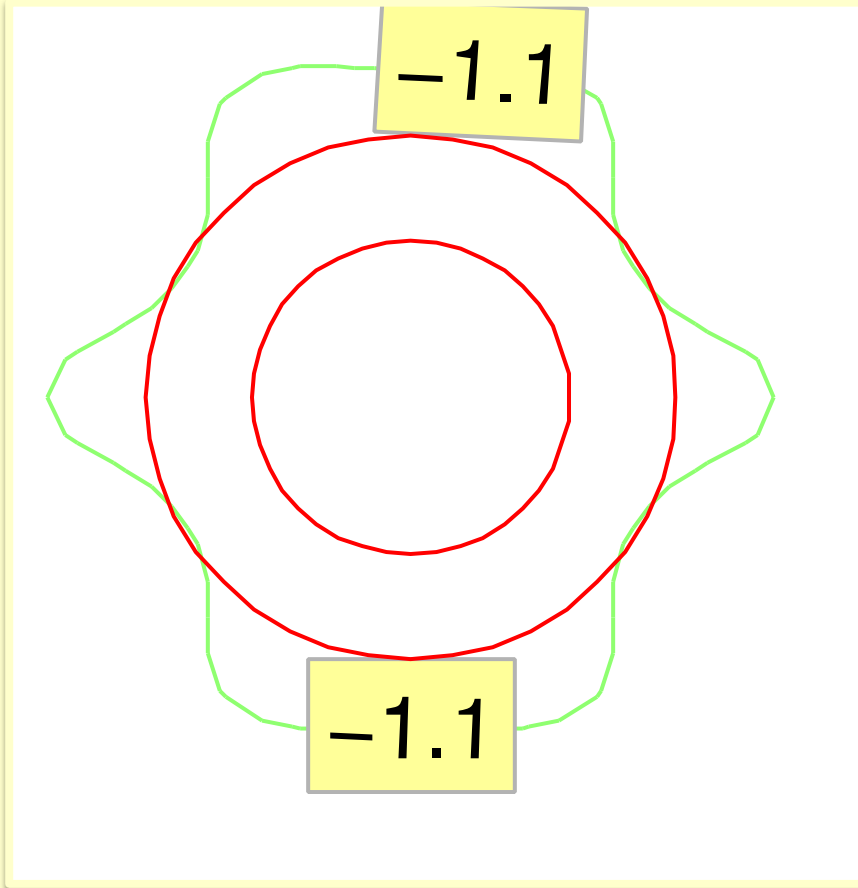
- ◆ **Linear sampling method (Colton-Kirsch 96);**  
**Factorization method (Kirsch 98);**  
**Point source & multipole method (Potthast 98);**  
**Probe method (Potthast 01);**  
Reciprocity Gap Sampling Method (Colton-Haddar, 05)  
Subspace-based optimization method (Chen 08)  
... ..

- ◆ **Monographs:**  
Potthast, Chapman & Hall, 01;  
Kirsch, Grinberg, Oxford 07;  
Cakoni, Colton, Monk: SIAM 11;  
Cakoni, Colton, Springer 14;  
Nakamura, Potthast, IOP, 15;  
X Chen, Wiley, 2018; ... ..

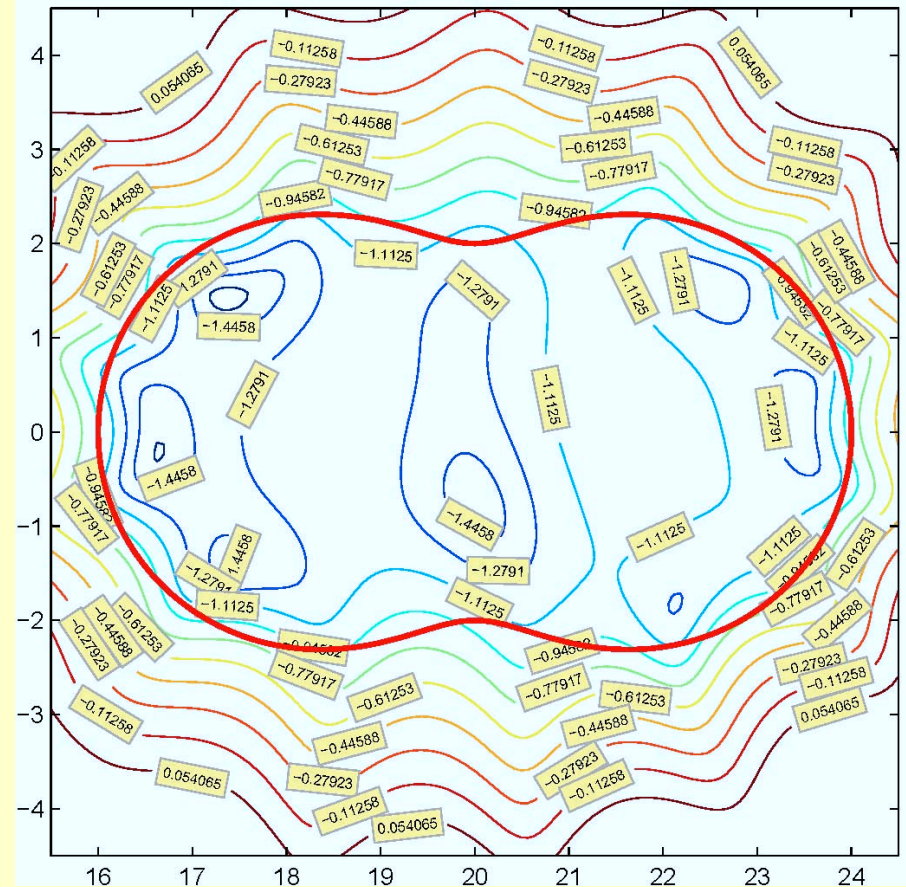
**But**

**when we apply these methods,  
we may still encounter  
several common difficulties**

# (I) Cut-off Values & Noise

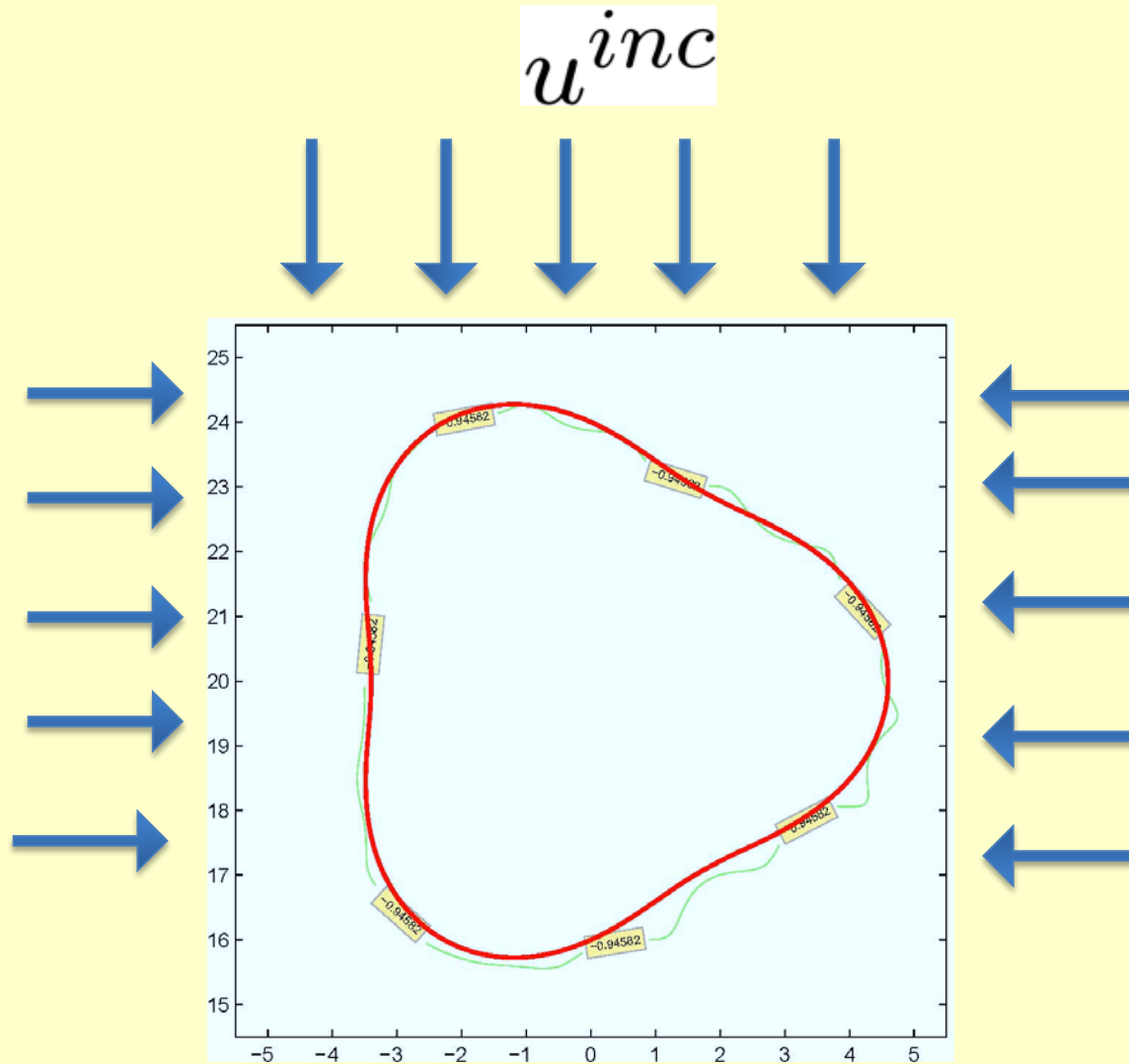


6 incidents & 30 receivers



inaccurate cut-off values

## (II) Large Data for LSMs



**And LSMs**

 **derived only for wave-type inverse problems**



# Find methods for more realistic cases

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- ◆ Apply even with data from a single incident field or a single set of Cauchy data
- ◆ Insensitive to data noise
- ◆ Involve no solutions of ill-posed & well-posed linear or nonlinear systems
- ◆ Apply to general inverse problems
  - ➔ Clearly, hard to have efficient methods for all these
  - ➔ Let us try what we can do

# DSMs for General Inverse Problems

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◆ Inverse acoustic medium scattering, Ito-Jin-Zou 12;

Inverse EM medium scattering, Ito-Jin-Zou 13;

◆ Non-wave type IPs:

Electric impedance tomography, Chow-Ito-Zou 14;

Diffusive optical tomography, Chow-Ito-Liu-Zou 14 ;

Moving objects, Chow-Ito-Zou 16;

Several other important applications, Chow-Han-Zou 20

# General Framework of DSM

(Chow-Ito-Zou 2019)

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- ◆ Define a Sobolev dual product on  $\Gamma$  with index  $\gamma$  :

$$\langle \chi, \phi \rangle_{\gamma, \Gamma} \quad \forall \chi \in Y, \phi \in Z$$

- ◆ Select probing & testing funcs  $\{\eta_x\}$ ,  $\{\mu_x\}$  based on PDEs

(1) nearly orthogonal wrt  $\langle \cdot, \cdot \rangle_{\gamma}$ , i.e.,  $\forall x \in \Omega, y \in D$ ,

kernel 
$$K(x, y) = \frac{\langle \eta_x, \mu_y \rangle_{\gamma}}{|\eta_x|_Y} \quad \text{like a Gaussian}$$

(2) family of testing funcs is fundamental over testing points:

$$u - u_0 \approx \sum_k a_k \mu_{x_k} \quad \text{on } \Gamma$$

# General Index functions for DSMs

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◆ We define the index function

$$I(x) := \frac{\langle \eta_x, u - u_0 \rangle_{\gamma, \Gamma}}{|\eta_x|_Y} \quad \forall x \in \Omega$$

◆ Then the index provides a probability :

$$I(x) \approx \sum_k a_k \frac{\langle \eta_x, \mu_{x_k} \rangle_{\gamma, \Gamma}}{|\eta_x|_Y}$$

# DSM for Acoustic Media

## (Ito-Jin-Zou 2011)

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◆ Acoustic wave, TM or TE mode :

$$\Delta u + k^2 n^2(x) u = 0$$

◆ Fundamental solution  $G$  :

$$\Delta G + k^2 G = \delta(x - y)$$

◆ By Lippmann-Schwinger representation:

$$u^s(x) = \int_{\tilde{\Omega}} G(x, y) I(y) dy \approx \sum w_j G(x, y_j)$$

◆ From the above:

$$\int_{\Gamma} u^s(x) \bar{G}(x, x_p) ds \approx k^{-1} \sum w_j \text{Im}(G(y_j, x_p))$$

# Direct Sampling Algorithm

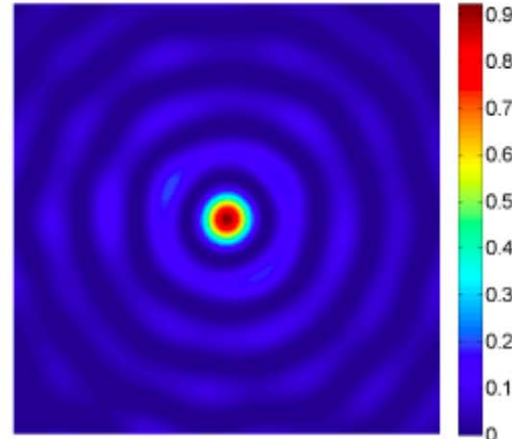
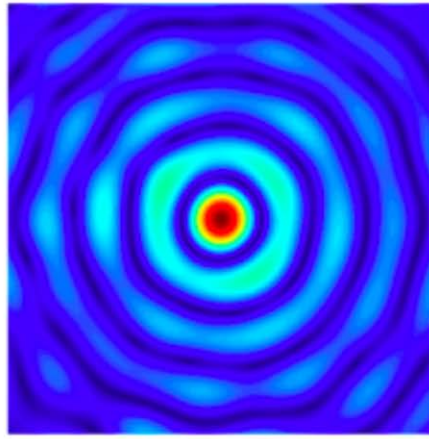
(Ito-Jin-Zou 2011)

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◆ Index func for probability of sampling point:

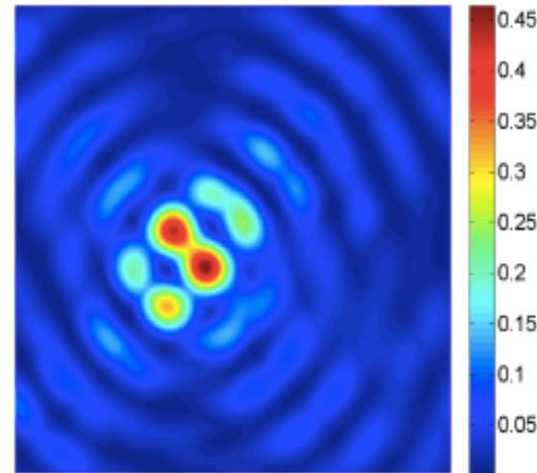
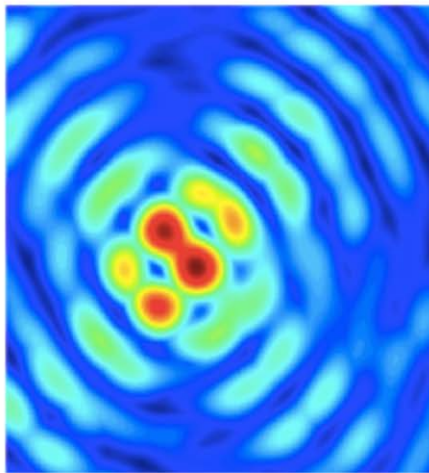
$$\Phi(x_p) = \frac{|\langle u^s, G(\cdot, x_p) \rangle_\Gamma|}{\|u^s\| \|G(\cdot, x_p)\|}$$

# Numerical Examples I



$\phi$

$\phi^2$



Two incidents: 20% noise

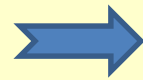
# DSM for Inverse EM Media Scattering

(Ito-Jin-Zou 2013)

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◆ Time harmonic EM system :

$$\begin{aligned} i\omega\epsilon E + \nabla \times H &= 0 \quad \text{in } \mathbb{R}^d \\ -i\omega\mu H + \nabla \times E &= 0 \quad \text{in } \mathbb{R}^d \end{aligned}$$



$$\nabla \times (\nabla \times E) - k^2 n^2(x) E = 0$$

◆ Fundamental solution  $G$  :  $(-\Delta - k^2)G(x, y) = \delta(x - y)$

➔ Maxwell fundamental soln:

$$\Phi(x, y) = k^2 G(x, y) I + D^2 G(x, y)$$



# Direct Sampling Algorithm

(Ito-Jin-Zou 2013)

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◆ Nearly orthogonality:

$$\int_{\Gamma} (\Phi(x, x_p)p, \bar{\Phi}(x, x_q)q) ds \approx k^{-1}(p, \mathfrak{S}(\Phi(x_p, x_q))q) \quad \forall p \in \mathbb{C}^d, q \in \mathbb{R}^d$$

◆ By Lippmann-Schwinger representation:

➔ 
$$E^s(x) = \int_{\Omega} \Phi(x, y)J(y)dy \approx \sum_j \Phi(x, y_j)J(y_j) |\tau_j|,$$

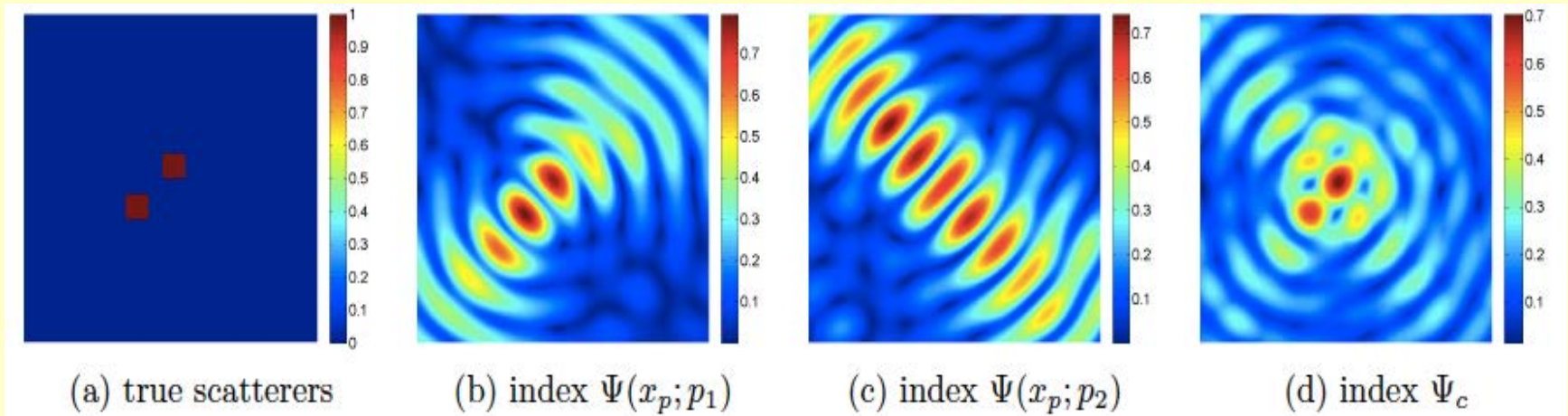
$$\langle E^s, \Phi(\cdot, x_p)q \rangle_{L^2(\Gamma)} \approx k^{-1} \sum_j |\tau_j| (J(y_j), \mathfrak{S}(\Phi(x_p, y_j))q)$$

◆ Index func for probability of sampling point:

$$\Psi(x_p; q) = \frac{|\langle E^s, \Phi(\cdot, x_p)q \rangle_{\Gamma}|}{\|E^s\|_{\Gamma} \|\Phi(\cdot, x_p)q\|_{\Gamma}}$$

# Numerical Examples I

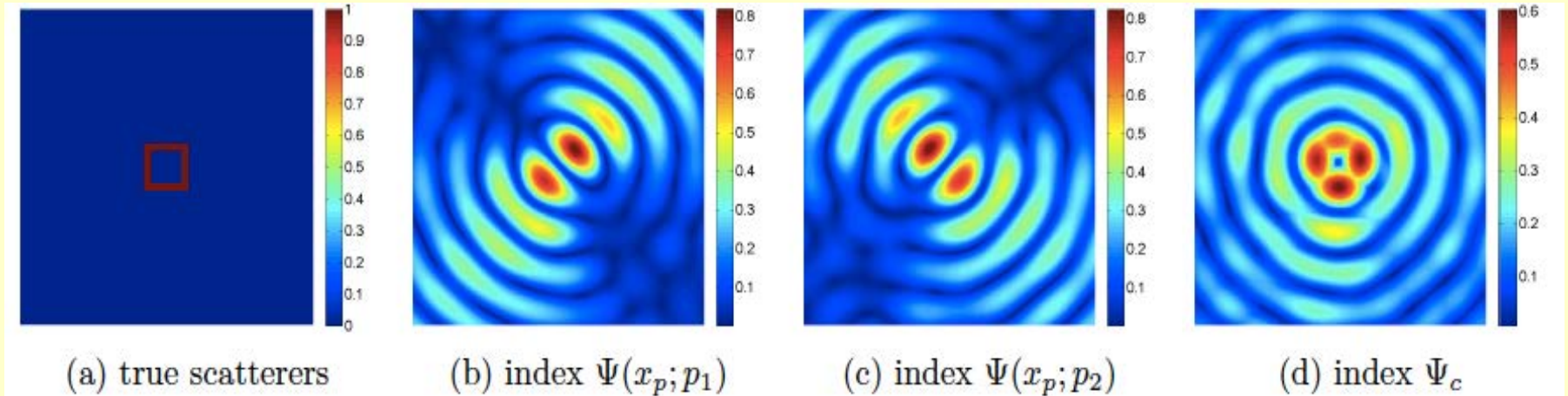
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Two incidents, same polarizations  $p$  &  $q$ : 20% noise

# Numerical Examples II

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**Two incidents, same polarizations p & q: 20% noise**

# DSM for EIT

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◆ Electrical Impedance Tomography:

$$\nabla \cdot (\sigma \nabla u) = 0 \quad \text{in } \Omega$$

Inject current on  $\Gamma$ :  $g = \sigma \frac{\partial u}{\partial \nu}$

Measure potential on  $\Gamma$ :  $f = u$

◆ **EIT** :  
given  $(f, g)$ , recover electrical conductivity  $\sigma(x)$

# Choice of Probing & Testing Spaces/Funcs

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◆ Define on the measurement surface  $\Gamma$  :

$$\langle \chi, \phi \rangle_{\gamma, \Gamma} := \langle (-\Delta_{\Gamma})^{\gamma} \chi, \phi \rangle \quad \forall \chi \in H^{2\gamma}(\Gamma), \phi \in L^2(\Gamma)$$

◆ Select probing & testing funcs  $\{\eta_x\}, \{\mu_y\}$  s.t.

(1) Nearly orthogonal wrt  $\langle \cdot, \cdot \rangle_{\gamma}$ , i.e.,  $\forall x \in \Omega, y \in D$ ,

$$K(x, y) = \frac{\langle \eta_x, \mu_y \rangle_{\gamma, \Gamma}}{|\eta_x|_Y} \quad \text{like a Gaussian}$$

(2) The testing family is fundamental:

$$u - u_0 \approx \sum_k a_k \mu_{y_k} \quad \text{on } \Gamma$$

# Choice of Probing Functions

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◆ Define

$$-\Delta w_{x,d} = -d \cdot \nabla \delta_x \quad \text{in } \Omega; \quad \frac{\partial w_{x,d}}{\partial \nu} = 0 \quad \text{on } \partial\Omega$$

◆ Dipole potential :

$$D_{x,d}(\xi) := c_n \frac{(x-\xi) \cdot d}{|x-\xi|^n}, \quad \xi \in \mathbb{R}^n$$

Set  $\varphi_{x,d} = D_{x,d} - w_{x,d}$  :

$$-\Delta \varphi_{x,d} = 0 \quad \text{in } \Omega; \quad \frac{\partial \varphi_{x,d}}{\partial \nu} = \frac{\partial D_{x,d}}{\partial \nu} \quad \text{on } \partial\Omega$$

◆ Probing functions as dir. derivative of Green funcs :

$$\eta_{x,d}(\xi) := w_{x,d}(\xi) = -d \cdot \nabla G_x(\xi) \quad \forall \xi \in \Gamma$$

# Probing functions for special geometries

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◆ For 3D spheric measurement surface :

$$\eta_{x,d}(\xi) = \frac{d \cdot \xi - \frac{(x - \xi) \cdot d}{|x - \xi|}}{\sqrt{4\pi} (|x - \xi| - x \cdot \xi + 1)}$$

◆ For 2D circular measurement curve :

$$\eta_{x,d}(\xi) = \frac{1}{\pi} \frac{(\xi - x) \cdot d}{|x - \xi|^2}$$

# Verification of Fundamental Properties

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◆ For p.w. constant inclusions  $\Omega_1, \Omega_2, \dots, \Omega_k$  :

$$(u - u_0)(\xi) = - \sum_i \int_{\partial\Omega_i} [\eta] \frac{\partial G_\xi}{\partial \nu} ds \approx \sum_k a_k \eta_{x_k, d_k}(\xi)$$

so testing funcs take the same as probing, with  $d_k = \nu(x_k)$

◆ Similarly for p.w. smooth inclusions



# Verification of Othogonality

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◆ For circular measurement curve :

$$\langle \eta_{x,d_x}, \mu_{y,d_y} \rangle_{\gamma, \mathbb{S}^1} = 2\text{Re} \left( \frac{e^{i(\theta_{d_x} - \theta_{d_y} - \theta_x + \theta_y)}}{r_x r_y} G^{2\gamma}(r_x r_y e^{i(\theta_x - \theta_y)}) \right)$$

with a complex polynomial

$$G^\beta(z) := \left( z \frac{\partial}{\partial z} \right)^\beta \left( \frac{1}{1-z} \right) = \sum_{m=0}^{\infty} m^\beta z^m$$

so when  $y \approx x$  and  $d_y \approx d_x$ , like a Gaussian

◆ Similarly for spherical measurement surface, but much more technical

# Index Function

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◆ Index function for EIT :

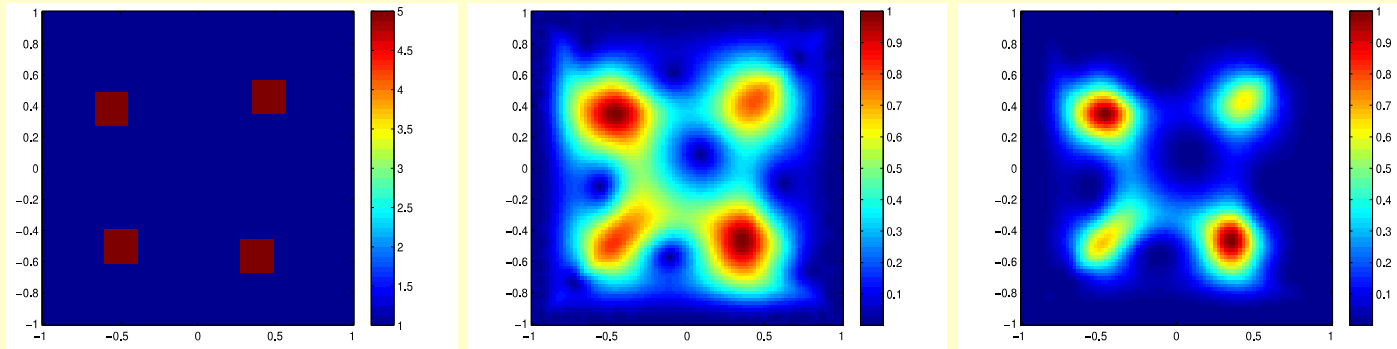
$$K(x, y) = \frac{\langle \eta_x, G_y \rangle_\gamma}{|\eta_x|_Y} = \frac{\langle (-\Delta_\Gamma)^\gamma \chi, \phi \rangle}{|\eta_x|_Y}$$

With the Sobolev index

$$\gamma = 2$$

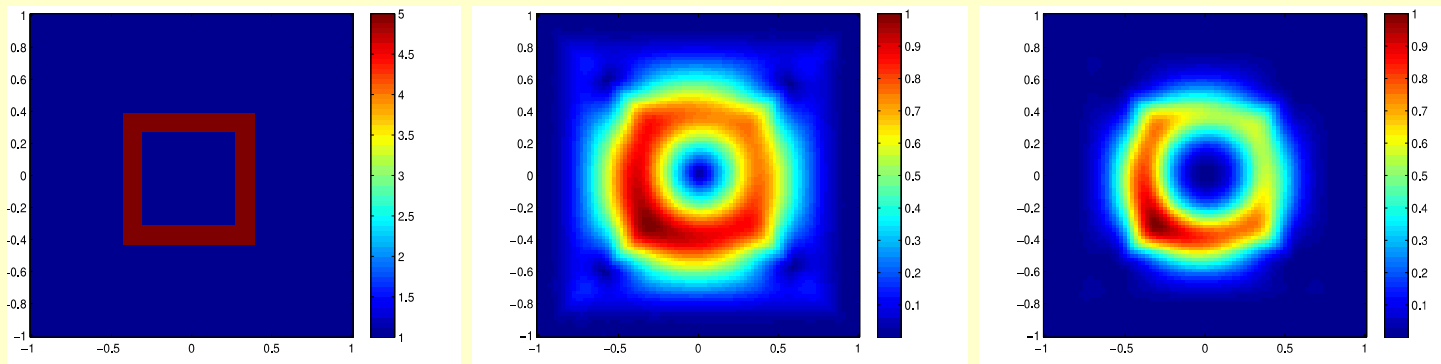
# Numerical Experiments

◆ Four separated square objects



5% noise

◆ Thin square ring object:



# DSM for DOT

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- ◆ Diffusive optical tomography in absorption medium  $\Omega$  with absorption coeff  $\mu$  & photon density  $u$ :

$$-\Delta u + \mu u = 0 \quad \text{in } \Omega$$

Inject current on  $\Gamma$ :  $g = \frac{\partial u}{\partial \nu}$

Measure density on  $\Gamma$ :  $f = u$

- ◆ **DOT** :  
given  $(f, g)$ , recover the absorption coeff  $\mu$

# General Principle of DSM

---

◆ Define on the measurement surface  $\Gamma$  :

$$\langle \chi, \phi \rangle_{\gamma, \Gamma} := \langle (-\Delta_{\Gamma})^{\gamma} \chi, \phi \rangle \quad \forall \chi \in H^{2\gamma}(\Gamma), \phi \in L^2(\Gamma)$$

◆ Select a set of probing & testing funcs  $\{\eta_x\}$  &  $\{\mu_x\}$  :

(1) nearly orthogonal wrt  $\langle \cdot, \cdot \rangle_{\gamma}$ , i.e.,  $\forall x \in \Omega, y \in D$ ,

$$K(x, y) = \frac{\langle \eta_x, \mu_y \rangle_{\gamma, \Gamma}}{|\eta_x|_Y} \quad \text{like a Gaussian}$$

(2) family probing funcs is fundamental:

$$(u - u_0)(\xi) \approx \sum_k a_k \mu_{y_k}(\xi) \quad \forall \xi \in \Gamma$$

# Choice of Testing Functions

---

◆ Green function :

$$-\Delta G_x + \mu_0 G_x = \delta_x \quad \text{in } \Omega; \quad \frac{\partial G_x}{\partial \nu} = 0 \quad \text{on } \partial\Omega$$

◆ Scattered potential  $u - u_0$  on  $\Gamma$  :

$$(u - u_0)(\xi) = \int_D G_y(\xi) (\mu_0 - \mu(y)) u(y) dy \quad \forall \xi \in \Gamma$$

◆ Fundamental representation :

$$(u - u_0)(\xi) \approx \sum_k a_k G_{y_k}(\xi) \quad \forall \xi \in \Gamma$$

◆ Green functions: good candidates for testing funcs

# Choice of Probing Functions

---

◆ Green function :

$$-\Delta w_x + \mu_0 w_x = \delta_x \quad \text{in } \Omega; \quad w_x = 0 \quad \text{on } \Gamma; \quad \frac{\partial w_x}{\partial \nu} = 0 \quad \text{on } \partial\Omega \setminus \Gamma$$

◆ Fundamental solution in the whole space  $\Phi_x$

◆ Define  $\psi_x$  :

$$-\Delta \psi_x + \mu_0 \psi_x = 0 \quad \text{in } \Omega; \quad \psi_x = \Phi_x \quad \text{on } \Gamma; \quad \frac{\partial \psi_x}{\partial \nu} = \frac{\partial \Phi_x}{\partial \nu} \quad \text{on } \partial\Omega \setminus \Gamma$$

◆ Probing functions,  $w_x = \Phi_x - \psi_x$  :

$$\eta_x(\xi) := \frac{\partial w_x}{\partial \nu}(\xi) \quad \forall \xi \in \Gamma$$

# Probing functions for special geometries

---

◆ For 2D circular measurement curve :

$$\eta_x(y) = \frac{1 - |x|^2}{2\pi |x - y|^2} \quad \forall y \in \mathbb{S}^1$$

◆ Orthogonality or Gaussian like behaviour :

$$K(x, z) = \frac{\langle \eta_x, G_z \rangle_1}{|\eta_x|_1^{\frac{1}{2}} |\eta_x|_0^{\frac{3}{4}}} = C(x) \left\{ \frac{r_z r_x \cos(\theta_x - \theta_z) (1 + r_z^2 r_x^2) - 2r_z^2 r_x^2}{(1 - 2r_z r_x \cos(\theta_x - \theta_z) + r_z^2 r_x^2)^2} \right\}$$



# Index Function for DSM

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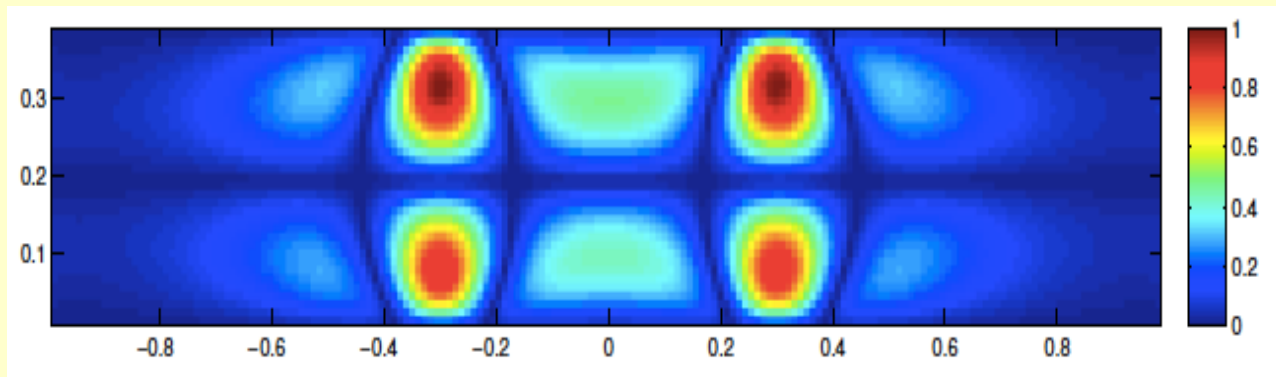
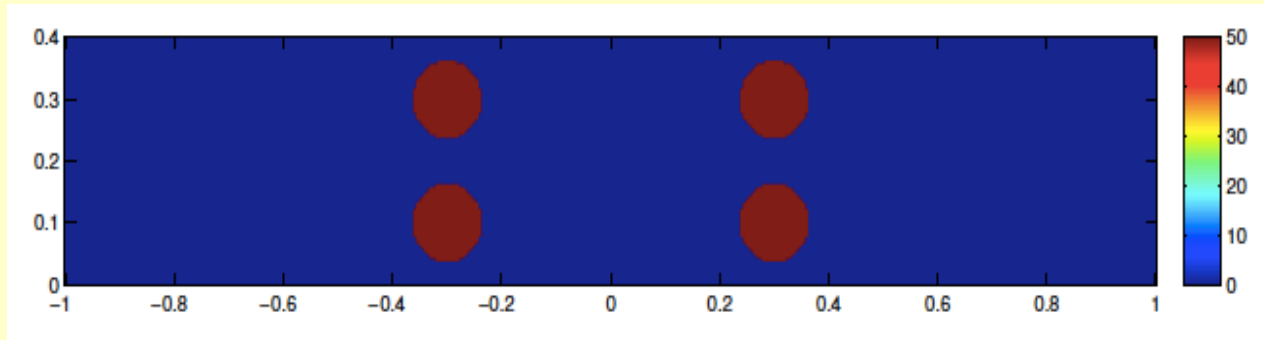
◆ Recall the kernel functions for DOT:

$$K(x, y) = \frac{\langle \eta_x, G_y \rangle_\gamma}{|\eta_x|_Y} = \frac{\langle (-\Delta_\Gamma)^\gamma \chi, \phi \rangle}{|\eta_x|_Y}$$

with the Sobolev index

$$\gamma = 1$$

# Example I (5% noise)



- ◆ Severely ill-posed, 4 inclusions close to each other & to the boundary, but reconstructions quite satisfactory:  
5% noise, only one Cauchy data, data far away from inclusions

# General Principle of time-dependent DSM

---

◆ Define a Sobolev dual product on  $\Gamma \times (\tau_0, T)$ :

$$\langle \chi, \phi \rangle_{\gamma, \Gamma \times (\tau_0, T)} \quad \forall \chi \in Y, \phi \in Z$$

◆ Select probing & testing funcs  $\{\eta_{x,t}\}$ ,  $\{\mu_{y,s}\}$  based on PDEs

(1) nearly orthogonal wrt  $\langle \cdot, \cdot \rangle_{\gamma}$ , i.e.,  $\forall y \in D, s \in (\tau_0, T)$ ,

**kernel func:** 
$$K(x, t; y, s) = \frac{\langle \eta_{x,t}, \mu_{y,s} \rangle_{\gamma, \Gamma \times (\tau_0, T)}}{|\eta_{x,t}|_Y} \quad \text{Gaussian}$$

(2) testing funcs are fundamental over set of testing points:

$$u - u_0 \approx \sum_{k,j} a_{k,j} \mu_{y_k, s_j} \quad \text{on } \Gamma \times (\tau_0, T)$$

# General Index functions for DSMs

---

◆ We define the index function

$$I(x, t) := \frac{\langle \eta_{x,t}, u - u_0 \rangle_{\gamma, \Gamma \times (\tau_0, T)}}{|\eta_{x,t}|_Y} \quad \forall x \in \Omega, t \in (0, T)$$

◆ Then the index provides a probability :

$$I(x, t) \approx \sum_k a_{k,j} \frac{\langle \eta_{x,t}, \mu_{y_k, s_j} \rangle_{\gamma, \Gamma \times (\tau_0, T)}}{|\eta_{x,t}|_Y}$$

# DSM for Moving Potential

---

◆ Heat conduction/moving DOT:

$$\frac{\partial u}{\partial t} = a\Delta u - q(x, t)u$$

Measure heat intensity on  $\Gamma$ :  $u$   
corresponding to one single  $u_0$

◆ Inverse Problem:

*given  $u$ , recover  $q(x, t)$*

# Testing Functions

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◆  $u_0$  : heat intensity with background potential  $q_0$

$$\frac{\partial(u-u_0)}{\partial t} - a\Delta(u-u_0) = -q_0(u-u_0) - (q-q_0)u$$

◆ we have  $(u-u_0)(x,t) = - \int_0^T \int_{D(t)} \Phi(x-y, t-s) c(y,s) dy ds$

with fundamental solution  $\Phi(x,t) = \frac{1}{4\pi at} \exp\left(-\frac{|x|^2}{4at}\right)$

◆ Therefore  $(u-u_0)(x,t) \approx \sum_{k,j} c_{kj} \Phi(x-y_k, t-s_j) \quad \forall (x,t) \in \Gamma \times (0,T)$

◆ Probing functions :

$$\eta_{x,t} := \Phi_{x,t}(y,s) \equiv \Phi(x-y, t-s) \chi_+(t-s-\delta)$$

# Index Function

---

◆ Define on the measurement surface :

$$\langle \chi, \phi \rangle_{\alpha, \Gamma \times (0, t)} := \langle \Delta_x^\alpha \chi, \phi \rangle \quad \forall \chi \in H^{2\alpha}(\Gamma), \phi \in L^2(\Gamma)$$

[not surface Laplacian this time](#)

◆ DSM index functions :

$$I_0^\alpha(x, t) = \frac{\langle \eta_{x, t}, u - u_0 \rangle_{\alpha, \Gamma \times (0, t)}}{|w_{x, t}^\alpha|_Y}$$

◆ Normalization :

$$\hat{I}_0^\alpha(x, t) = \frac{|I_0^\alpha(x, t)|}{\max |I_0^\alpha(x, t)|}$$

# Index Function: real-time

---

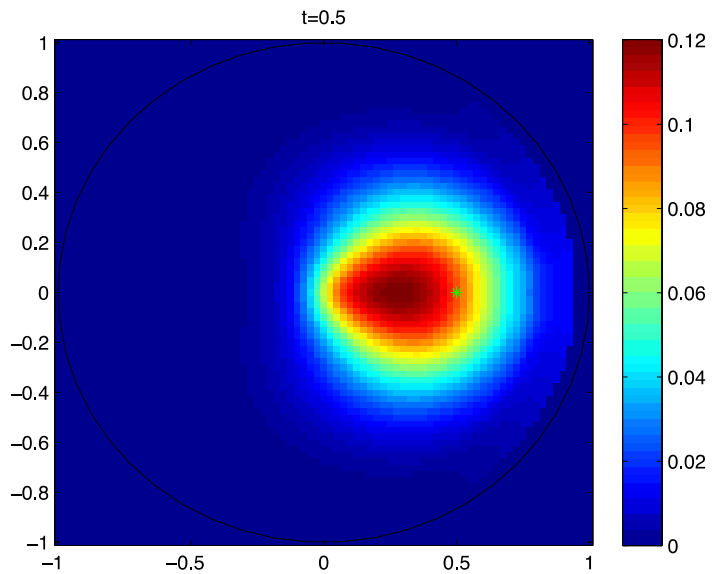
◆ DSM index functions : real time reconstruction

$$I_0^\alpha(x, t) = \frac{\langle \eta_{x,t}, u - u_0 \rangle_{\alpha, \Gamma \times (0, t)}}{|w_{x,t}^\alpha|_Y}$$

➔ no any data after time t needed

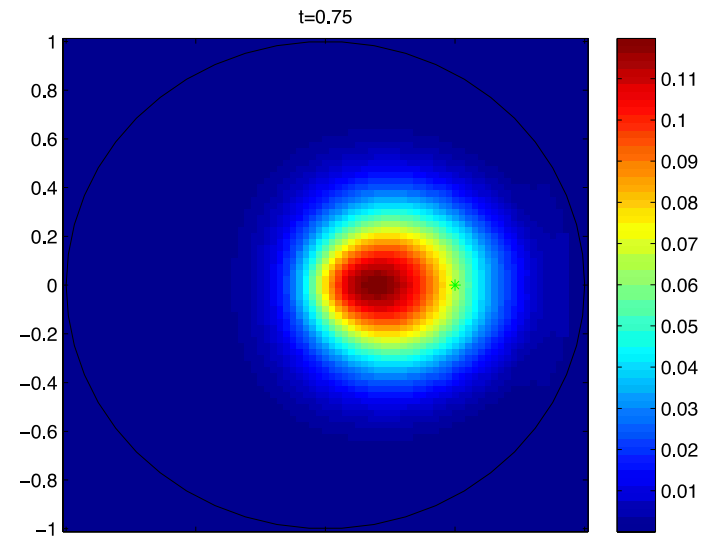


# Behavior of index for point source $q = \delta_{(0.5,0)}(x)\delta_1(t)$

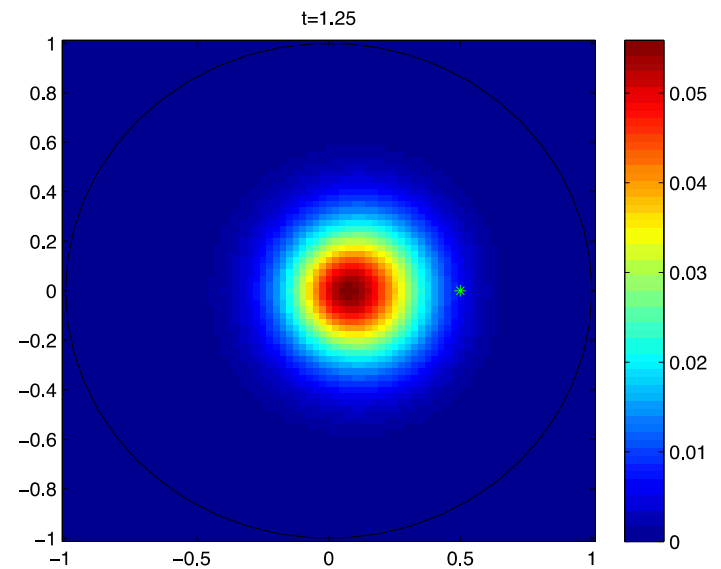
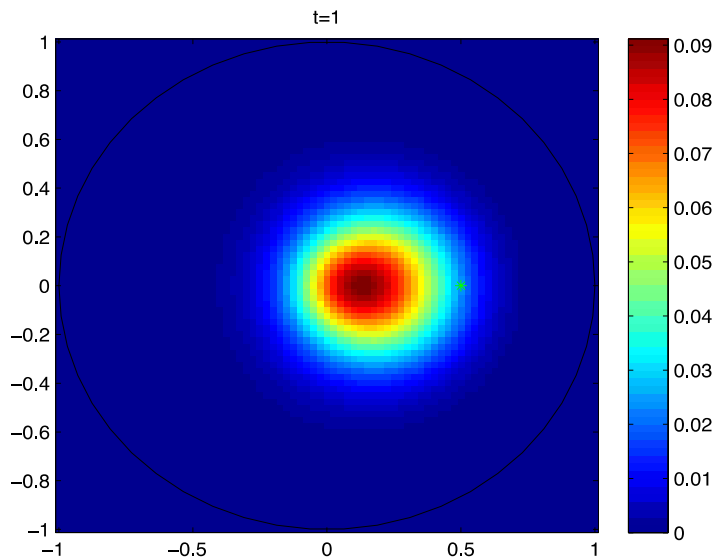


zeroth  
order  
index  
 $I_0^\alpha$

$$\alpha = 2$$



max  
at  
t=0.5,  
far  
from  
t=1,  
further  
away



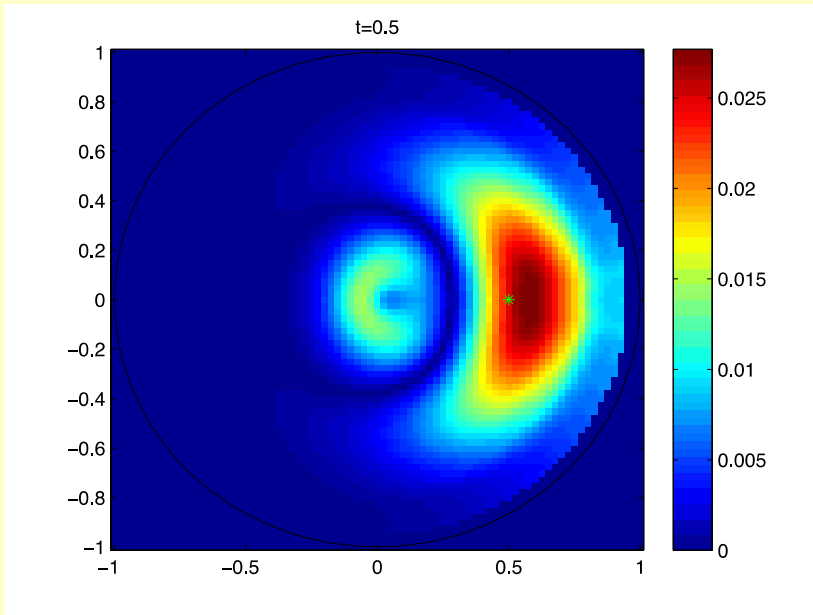
# Temporal derivatives of zeroth order index $I_0^\alpha$

---

- ◆ From the behaviour of  $I_0^\alpha$ , we see big drop in spatial maximum with time as time goes on from  $t=1$ , so a rate of change of  $I_0^\alpha$  may capture the inclusion more effectively:

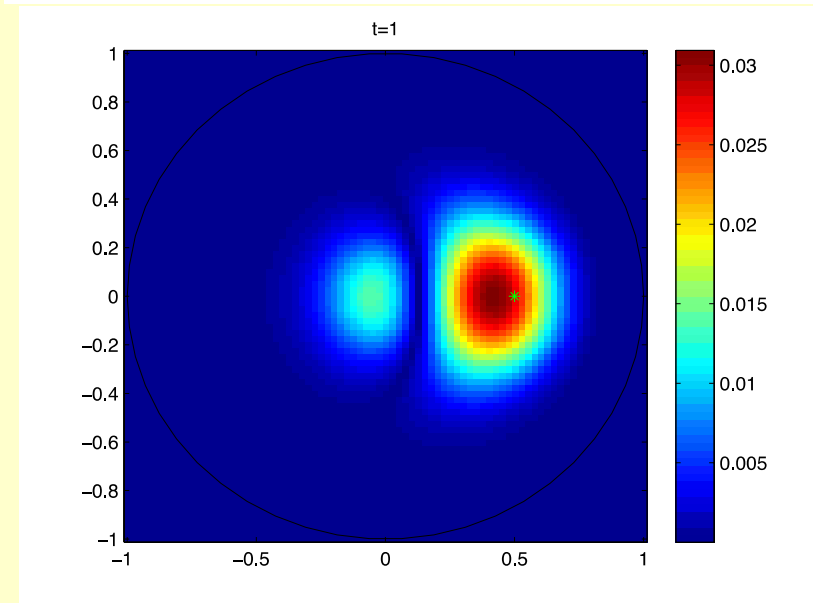
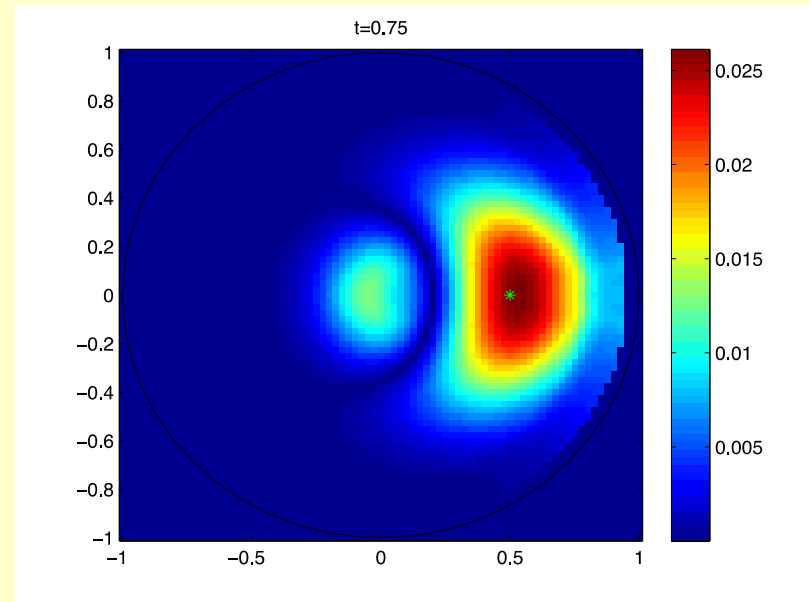
$$I_\gamma^\alpha = \frac{\partial^\gamma}{\partial t^\gamma} I_0^\alpha$$

# Behavior of index for point source $q = \delta_{(0.5,0)}(x)\delta_1(t)$

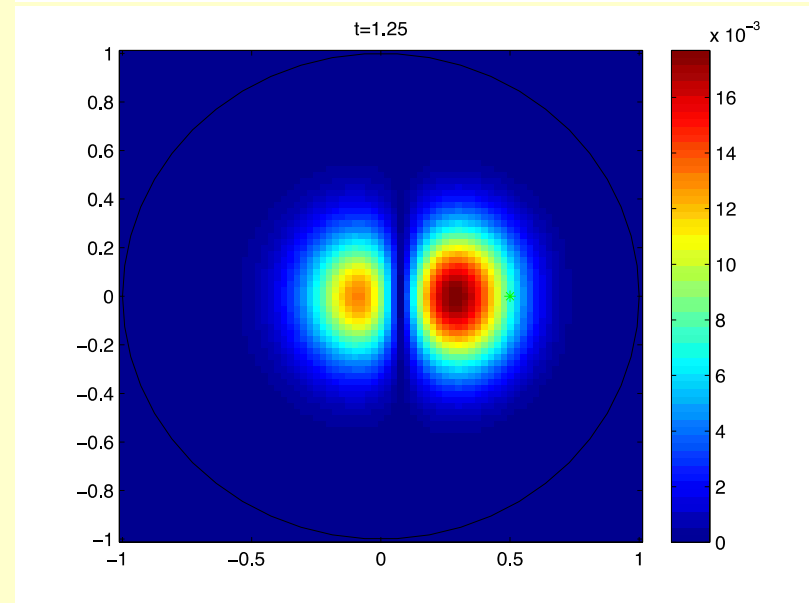


1<sup>st</sup>  
order  
index  
 $I_1^\alpha$

$$\alpha = 2$$



max  
well  
reached  
at  
t=1



# Verification of Index Function

---

◆ Consider the kernel

$$K_0^\alpha(x, t; y, s) = \frac{\int_0^{t-\delta} \int_\Gamma \Phi(y-z, s-k) \Delta_z^\alpha \Phi(x-z, t-k) d\sigma_z dk}{\sqrt{\int_0^{t-\delta} \int_\Gamma (\Delta_z^\alpha \Phi(x-z, t-k))^2 d\sigma_z dk}}$$

and its derivatives

$$K_\gamma^\alpha(x, y, t, s) := \partial_t^\gamma K_0^\alpha(x, y, t, s)$$

For some  $t > t_0$ ,

$$\partial_t \left( \sqrt{\int_0^{t-\delta} \int_\Gamma (\Delta_z^\alpha \Phi(x-z, t-k))^2 d\sigma_z dk} \right) = O(t_0^{-2\alpha-2})$$

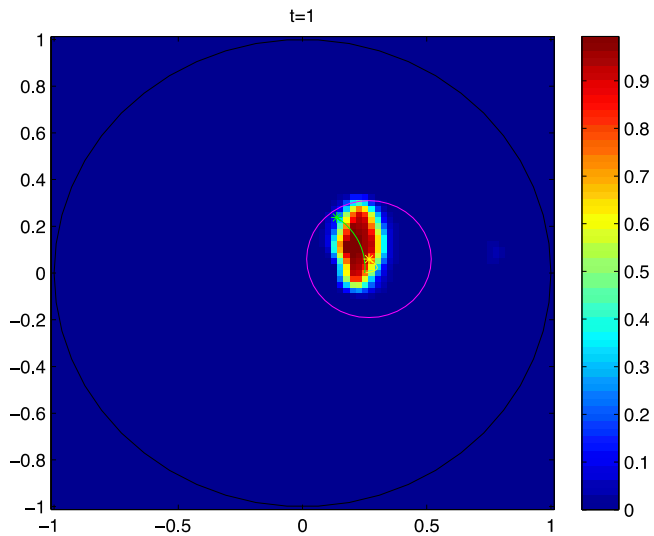
➔ Explicit relation for  $\alpha, \gamma \in \mathbb{N}$ ,  $t > t_0$ :

$$K_\gamma^\alpha(x, t; y, s) = \frac{\partial_t^\gamma \left( \int_0^{t-\delta} \int_\Gamma \Phi(y-z, s-k) \Delta_z^\alpha \Phi(x-z, t-k) d\sigma_z dk \right)}{\sqrt{\int_0^{t-\delta} \int_\Gamma (\Delta_z^\alpha \Phi(x-z, t-k))^2 d\sigma_z dk}} + O(t_0^{-2\alpha-2})$$

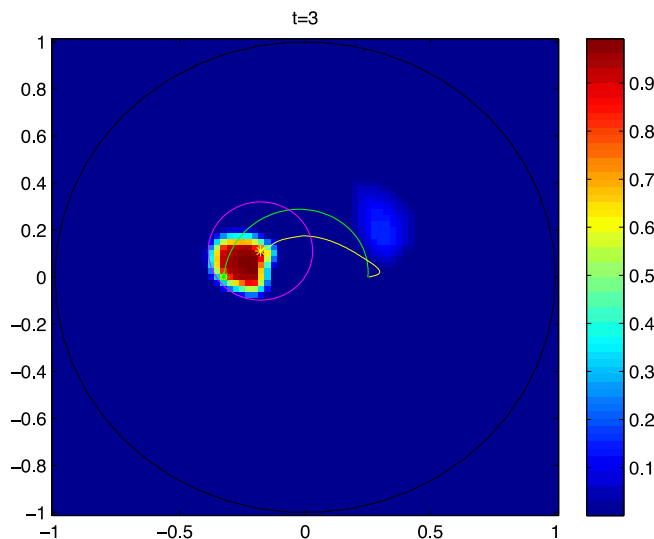
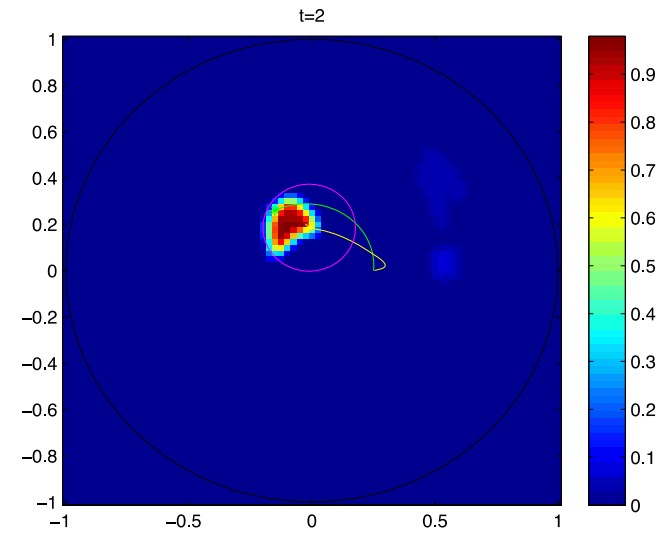
➔ Max at  $y = x$ ,  $s = t$ , but shift away more if  $\alpha - \gamma$  bigger

# Numerical Experiments I

$$\Gamma(t) = \left( \frac{t}{8T} + 0.25 \right) \left( \cos \left( \frac{t\pi}{3} \right), \sin \left( \frac{t\pi}{3} \right) \right), \quad t \in (0, 5)$$

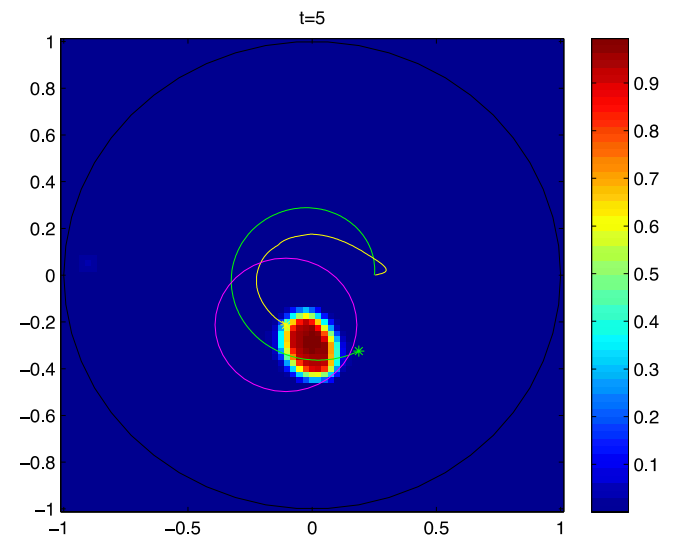


there is  
a time lag,  
reconstructed  
inclusion  
follows  
closely  
exact inclusion



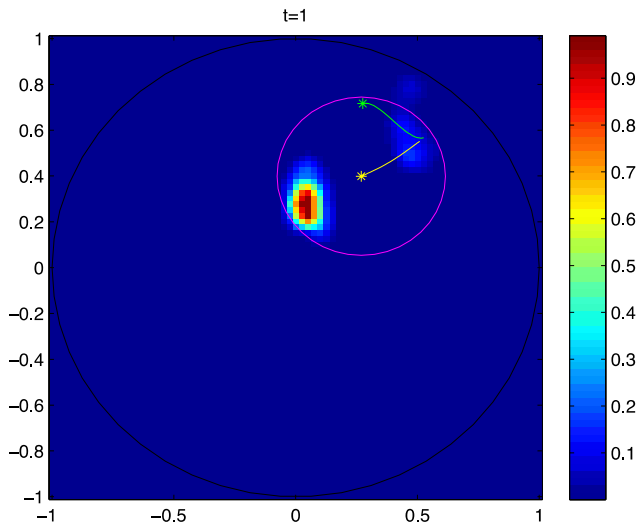
5% noise

green \*  
yellow  
:  
centre of  
inclusion  
mass

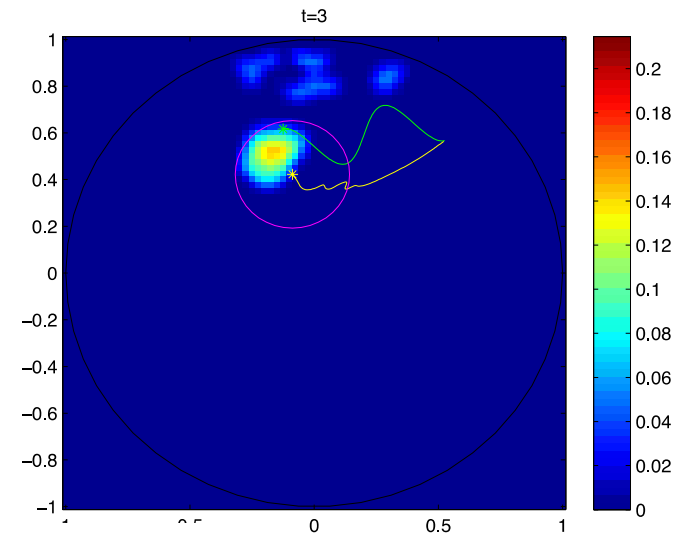


# Numerical Experiments II

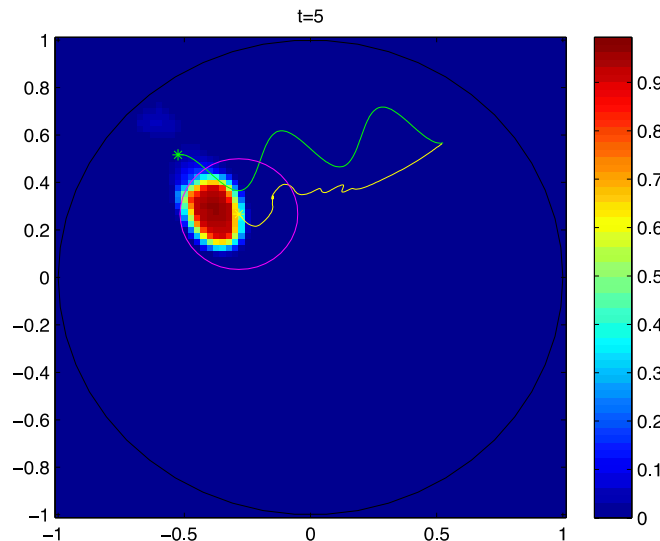
$$\Gamma(t) = \left( -\frac{t}{5} + \frac{1}{2} + \frac{1}{40} \cos(t\pi), -\frac{t}{20} + \frac{2}{3} - \frac{1}{0} \cos(t\pi) \right), \quad t \in (0, 5)$$



once it  
succeeds  
to approach  
exact inclusion  
for  $t > 2$ , it starts  
to follow  
exact path



Initially, for  $t < 2$ ,  
the reconstructed  
inclusion  
tries to find  
the exact inclusion

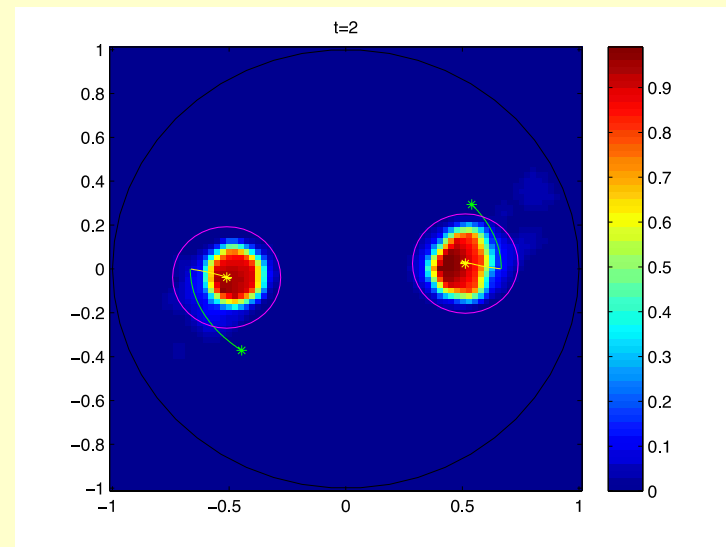
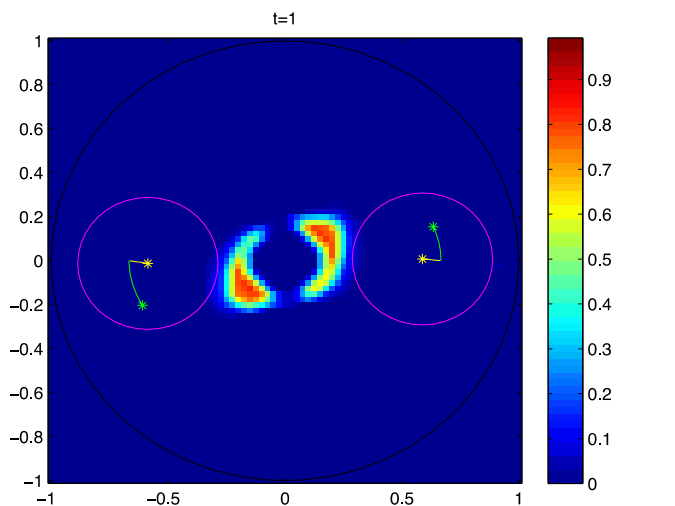


recovered  
trajectory can  
even follow  
very fine turnings  
as exact one from  
 $t > 4$  onwards

# Numerical Experiments III

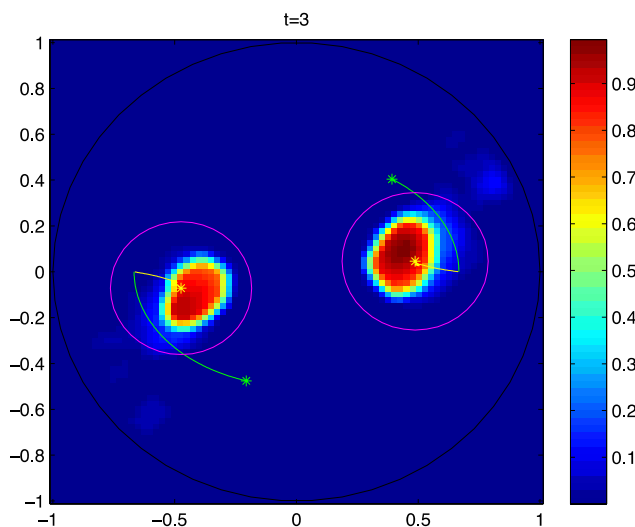
$$\Gamma_1(t) = \left( \frac{2}{3} \cos\left(\frac{t\pi}{10}\right), \frac{1}{2} \sin\left(\frac{t\pi}{10}\right) \right), \quad \Gamma_2(t) = \left( -\frac{2}{3} \cos\left(\frac{2t\pi}{15}\right), -\frac{1}{2} \sin\left(\frac{2t\pi}{15}\right) \right)$$

**2 objects,  
with different  
speeds,  
highly  
ill-posed**



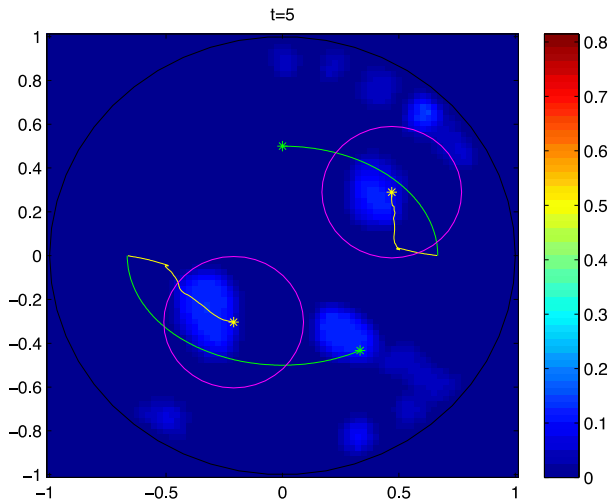
**initially, strongly  
coupling,**

**gradually,  
clearly  
seen  
2 objects,**

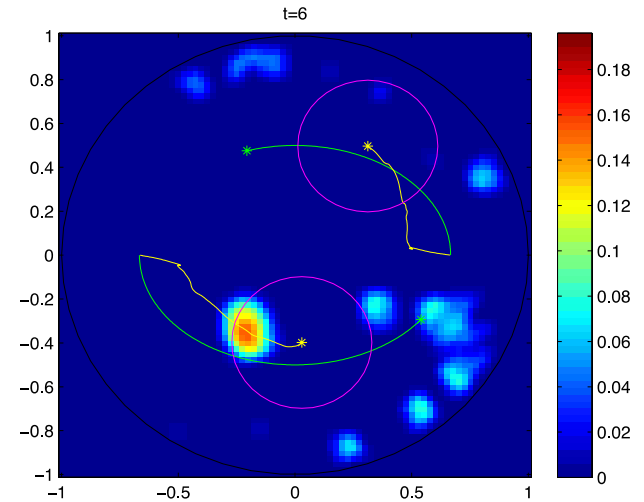


# Numerical Experiments III

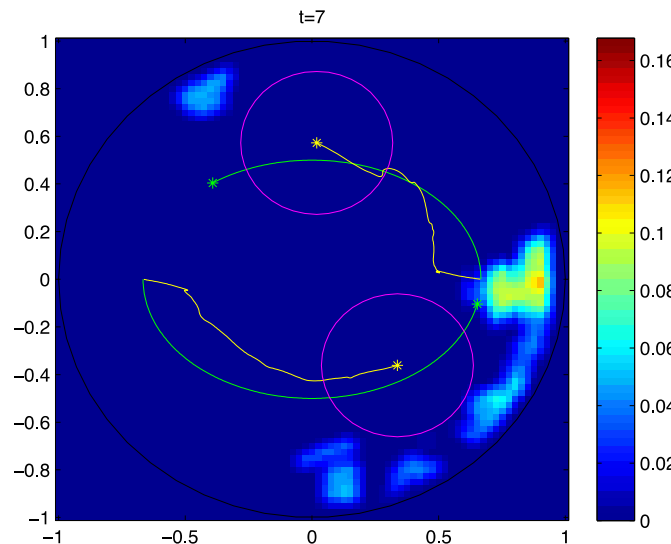
$$\Gamma_1(t) = \left( \frac{2}{3} \cos\left(\frac{t\pi}{10}\right), \frac{1}{2} \sin\left(\frac{t\pi}{10}\right) \right), \quad \Gamma_2(t) = \left( -\frac{2}{3} \cos\left(\frac{2t\pi}{15}\right), -\frac{1}{2} \sin\left(\frac{2t\pi}{15}\right) \right)$$



after long time,  
signal to noise  
weak,  
less stable,  
more  
oscillatory



2 objects,  
with one set  
of data,  
very  
challenging  
task



still tracing  
2 objects  
reasonably  
well



# An Optimal Control framework

---

◆ Forward equation:

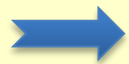
$$L_q(u) = 0, \quad Bu = f$$

◆ Background equation:

$$L_{q_0}(u_0) = 0, \quad Bu_0 = f$$

◆ Parameter-to-solution:

$$L_{q_0}(u - u_0) = -(L_q - L_{q_0})(u) := J(q - q_0)$$



$$u - u_0 = G [J(q - q_0)]$$

# An Optimal Control Framework

---

◆ Parameter-to-solution:

$$u - u_0 = G [J(q - q_0)]$$



$$E : u - u_0 \rightarrow (u - u_0)|_{\Gamma}$$

◆ Index function :

$$I = (\Phi \circ W_{X,\gamma}(\eta) \circ E \circ G) [J(q - q_0)]$$

◆ Hope  $I$  provides an estimate of support of  $J(c - c_0)$

$$\Phi \circ W_{X,\gamma}(\eta) \circ E \circ G \approx id : X \rightarrow X^*$$



$$\min_{\Phi, \gamma} \|\Phi \circ W_{X,\gamma}(\eta) \circ E \circ G - id\|_{X \rightarrow X^*}^2$$

# Index Function for DSM

---

◆ Recall the kernel function :

$$K(x, y) = \frac{\langle \eta_x, G_y \rangle_\gamma}{|\eta_x|_Y} = \frac{\langle (-\Delta_\Gamma)^\gamma \chi, \phi \rangle}{|\eta_x|_Y}$$

◆ Sobolev index :

Wave-type:	$\gamma = 0$
EIT:	$\gamma = 2$
DOT:	$\gamma = 1$

# Features of DSMs

---

- ◆ Computationally very cheap, completely parallel
- ◆ Stability: straightforward
- ◆ Works for a single measurement data
- ◆ Robust against noise in data, due to orthogonality:  
high frequency components in data orthogonal to  
fundamental solutions on measurement surface

# Other related sampling methods

---

- ◆ **R Potthast 2010, inverse obstacle scattering**
- ZM Chen et al. (since 2013):**  
**reverse time migration, inverse obstacle acoustic & EM scattering**
- H Ammari, et al.**
- WK Park, et al.**
- HY Liu, XD Liu, JZ Li, YK Guo, ... ..**
- ... ..**

 **Mostly for inverse wave scattering**

**THANK YOU!**